

<b>Notice of References Cited</b>		Application/Control No.	Applicant(s)/Patent Under Reexamination HIROFUMI DODORO ET AL	
		Examiner Deborah Yee	Art Unit 1742	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-5,998,042	12-1999	Tanaka et al.	428/627
	B	US-6,086,686	07-2000	Tanaka et al.	148/325
	C	US-			
	D	US-			
	E	US-			
	F	US-			
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	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
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**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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